

## CD4069UB CMOS ヘクス・インバータ

### 1 特長

- 標準化された対称出力特性
- 中程度の速度での動作：10V で  $t_{PHL}$ 、 $t_{PLH} = 30\text{ns}$  (標準値)
- 20V で静止電流を 100% テスト済み
- パッケージの温度範囲全体で 18V 時に最大入力電流  $1\mu\text{A}$ 、 $25^\circ\text{C}$  で 18V 時に  $100\text{nA}$
- JEDEC 暫定標準 No. 13B、「B シリーズ CMOS デバイスの記述の標準仕様」のすべての要件に適合

### 2 アプリケーション

- 論理反転
- パルス成形
- 発振器
- 高入力インピーダンスのアンプ

### 3 概要

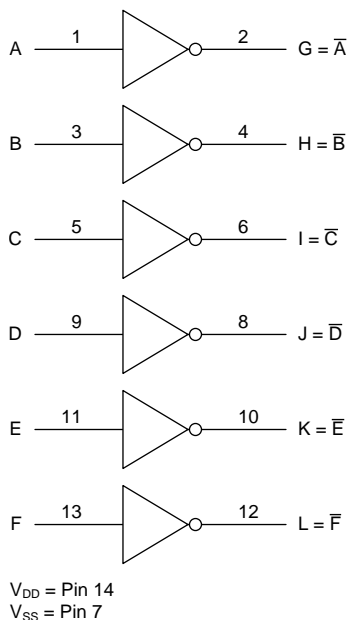
CD4069UB デバイスは、6 つの CMOS インバータ回路で構成されます。これらのデバイスは、(CD4009 や CD4049 ヘクス・インバータなどが持つ) 中程度の電力の TTL 駆動や論理レベル変換能力、およびバッファを必要としない、すべての汎用インバータ用途を目的としています。

#### 製品情報<sup>(1)</sup>

型番	パッケージ(ピン数)	本体サイズ(公称)
CD4069UBE	PDIP (14)	19.30mm×6.35mm
CD4069UBF	CDIP (14)	19.56mm×6.67mm
CD4069UBM	SOIC (14)	8.65mm×3.91mm
CD4069UBNSR	SO (14)	10.30mm×5.30mm
CD4069UBPW	TSSOP (14)	5.00mm×4.40mm

(1) 提供されているすべてのパッケージについては、データシートの末尾にある注文情報を参照してください。

#### CD4069UB の機能図



## 目次

1	特長	1	8.3	Feature Description	13
2	アプリケーション	1	8.4	Device Functional Modes	13
3	概要	1	9	<b>Application and Implementation</b>	14
4	改訂履歴	2	9.1	Application Information	14
5	<b>Pin Configuration and Functions</b>	3	9.2	Typical Application	14
6	<b>Specifications</b>	4	10	<b>Power Supply Recommendations</b>	16
6.1	Absolute Maximum Ratings	4	11	<b>Layout</b>	16
6.2	ESD Ratings	4	11.1	Layout Guidelines	16
6.3	Recommended Operating Conditions	4	11.2	Layout Example	16
6.4	Thermal Information	4	12	デバイスおよびドキュメントのサポート	17
6.5	Electrical Characteristics – Dynamic	5	12.1	デバイス・サポート	17
6.6	Electrical Characteristics – Static	5	12.2	ドキュメントのサポート	17
6.7	Typical Characteristics	8	12.3	コミュニティ・リソース	17
7	<b>Parameter Measurement Information</b>	9	12.4	商標	17
8	<b>Detailed Description</b>	13	12.5	静電気放電に関する注意事項	17
8.1	Overview	13	12.6	Glossary	17
8.2	Functional Block Diagram	13	13	メカニカル、パッケージ、および注文情報	17

## 4 改訂履歴

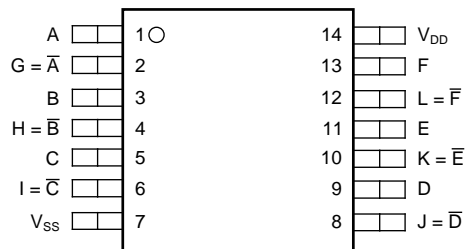
資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

Revision D (February 2016) から Revision E に変更	Page
• 「特長」の 2 番目の箇条書き項目で、 $t_{PHL}$ から余分な文字「-」を削除	1
• Corrected $V_I$ spec MIN/MAX values in the Abs Max Ratings table	4
• Corrected parameter $I_{DD}$ max term to $I_{DD}$ in the Elec Characteristics table	5
• Corrected parameter $I_{OL}$ min term to $I_{OL}$ in the Elec Characteristics table	5
• Corrected parameter $V_{OL}$ max term to $V_{OL}$ in the Elec Characteristics table	6
• Corrected parameter $V_{IL}$ max term to $V_{IL}$ in the Elec Characteristics table	6
• Corrected parameter $V_{IH}$ min term to $V_{IH}$ in the Elec Characteristics table	6
• Corrected parameter $I_{IN}$ max term to $I_{IN}$ in the Elec Characteristics table	7
• Added Y-axis label to <a href="#">Figure 1</a> image object	8
• Changed text string from " $-t_{PHL}$ " to "of $t_{PHL}$ " in the Feature Description paragraph.	13

Revision C (August 2003) から Revision D に変更	Page
• 「ESD 定格」の表、「機能説明」セクション、「デバイスの機能モード」セクション、「アプリケーションと実装」セクション、「電源に関する推奨事項」セクション、「レイアウト」セクション、「デバイスおよびドキュメントのサポート」セクション、「メカニカル、パッケージ、および注文情報」セクションを追加	1

## 5 Pin Configuration and Functions

**D, J, N, NS, and PW Packages**  
**14-Pin PDIP, CDIP, SOIC, SO, and TSSOP**  
**Top View**



**Pin Functions**

PIN		I/O	DESCRIPTION
NAME	NO.		
A	1	I	A input
B	3	I	B input
C	5	I	C input
D	9	I	D input
E	11	I	E input
F	13	I	F input
$G = \bar{A}$	2	O	G output
$H = \bar{B}$	4	O	H output
$I = \bar{C}$	6	O	I output
$J = \bar{D}$	8	O	J output
$K = \bar{E}$	10	O	K output
$L = \bar{F}$	12	O	L output
$V_{DD}$	14	—	Positive supply
$V_{SS}$	7	—	Negative supply

## 6 Specifications

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		MIN	MAX	UNIT
V <sub>DD</sub>	DC supply-voltage (voltages referenced to V <sub>SS</sub> terminal)	-0.5	20	V
V <sub>I</sub>	Input voltage, all inputs	-0.5	V <sub>DD</sub> + 0.5	V
I <sub>IK</sub>	DC input current, any one input	-10	10	mA
P <sub>D</sub>	Power dissipation per package	-55°C to 100°C	500	mW
		100°C to 125°C	12	
	Device dissipation per output transistor	Full range (all package types)	100	mW
Lead temperature <sup>(2)</sup>			265	°C
T <sub>J</sub>	Junction temperature		150	°C
T <sub>stg</sub>	Storage temperature	-65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) During soldering at distance 1/16 inch ± 1/32 inch (1.59 mm ± 0.79 mm) from case for 10 s maximum

### 6.2 ESD Ratings

		VALUE	UNIT
V <sub>(ESD)</sub>	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±500
		Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±200

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
V <sub>DD</sub>	Supply voltage	3	18	V
T <sub>A</sub>	Operating temperature	-55	125	°C

### 6.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>	CD4069UB					UNIT	
	D (SOIC)	J (CDIP)	N (PDIP)	NS (SO)	PW (TSSOP)		
	14 PINS	14 PINS	14 PINS	14 PINS	14 PINS		
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	94.9	—	57.9	91.2	122.1	°C/W
R <sub>θJC(top)</sub>	Junction-to-case (top) thermal resistance	56.4	28.5	45.5	48.8	50.8	°C/W
R <sub>θJB</sub>	Junction-to-board thermal resistance	49.2	—	37.7	50	63.8	°C/W
ψ <sub>JT</sub>	Junction-to-top characterization parameter	21.1	—	30.6	15	6.3	°C/W
ψ <sub>JB</sub>	Junction-to-board characterization parameter	48.9	—	37.6	49.6	63.3	°C/W
R <sub>θJC(bot)</sub>	Junction-to-case (bottom) thermal resistance	N/A	N/A	N/A	N/A	N/A	°C/W

- (1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](#).

## 6.5 Electrical Characteristics – Dynamic

 $T_A = 25^\circ\text{C}$ ; input  $t_r, t_f = 20\text{ ns}$ ;  $C_L = 50\text{ pF}$ ;  $R_L = 200\text{ k}\Omega$  (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_{PLH}, t_{PHL}$ Propagation delay time	$V_{DD} (V) = 5$		55	110	ns
	$V_{DD} (V) = 10$		30	60	
	$V_{DD} (V) = 15$		25	50	
$t_{THL}, t_{TLH}$ Transition time	$V_{DD} (V) = 5$		100	200	ns
	$V_{DD} (V) = 10$		50	100	
	$V_{DD} (V) = 15$		40	80	
$C_{IN}$ Input capacitance	Any input		10	15	pF

## 6.6 Electrical Characteristics – Static

 $T_A = 25^\circ\text{C}$ ; input  $t_r, t_f = 20\text{ ns}$ ;  $C_L = 50\text{ pF}$ ;  $R_L = 200\text{ k}\Omega$  (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$I_{DD}$ Quiescent device current	$V_{IN} = 0\text{V or } 5\text{ V}, V_{DD} = 5\text{ V}$	$T_A = -55^\circ\text{C}$		0.25	$\mu\text{A}$
		$T_A = -40^\circ\text{C}$		0.25	
		$T_A = 25^\circ\text{C}$	0.01	0.25	
		$T_A = 85^\circ\text{C}$		7.5	
		$T_A = 125^\circ\text{C}$		7.5	
	$V_{IN} = 0\text{ or } 10\text{ V}, V_{DD} = 10\text{ V}$	$T_A = -55^\circ\text{C}$		0.5	
		$T_A = -40^\circ\text{C}$		0.5	
		$T_A = 25^\circ\text{C}$	0.01	0.5	
		$T_A = 85^\circ\text{C}$		15	
		$T_A = 125^\circ\text{C}$		15	
	$V_{IN} = 0\text{ or } 15\text{ V}, V_{DD} = 15\text{ V}$	$T_A = -55^\circ\text{C}$		1	
		$T_A = -40^\circ\text{C}$		1	
		$T_A = 25^\circ\text{C}$	0.01	1	
		$T_A = 85^\circ\text{C}$		30	
		$T_A = 125^\circ\text{C}$		30	
	$V_{IN} = 0\text{ or } 20\text{ V}, V_{DD} = 20\text{ V}$	$T_A = -55^\circ\text{C}$		5	
$T_A = -40^\circ\text{C}$			5		
$T_A = 25^\circ\text{C}$		0.02	5		
$T_A = 85^\circ\text{C}$			150		
$T_A = 125^\circ\text{C}$			150		
$I_{OL}$ Output low (sink) current	$V_O = 0.4\text{ V}, V_{IN} = 5\text{ V}, V_{DD} = 5\text{ V}$	$T_A = -55^\circ\text{C}$	0.64		mA
		$T_A = -40^\circ\text{C}$	0.61		
		$T_A = 25^\circ\text{C}$	0.51	1	
		$T_A = 85^\circ\text{C}$	0.42		
		$T_A = 125^\circ\text{C}$	0.36		
	$V_O = 0.5\text{ V}, V_{IN} = 10\text{ V}, V_{DD} = 10\text{ V}$	$T_A = -55^\circ\text{C}$	1.6		
		$T_A = -40^\circ\text{C}$	1.5		
		$T_A = 25^\circ\text{C}$	1.3	2.6	
		$T_A = 85^\circ\text{C}$	1.1		
		$T_A = 125^\circ\text{C}$	0.9		
	$V_O = 1.5\text{ V}, V_{IN} = 15\text{ V}, V_{DD} = 15\text{ V}$	$T_A = -55^\circ\text{C}$	4.2		
		$T_A = -40^\circ\text{C}$	4		
		$T_A = 25^\circ\text{C}$	3.4	6.8	
		$T_A = 85^\circ\text{C}$	2.8		
		$T_A = 125^\circ\text{C}$	2.4		

**Electrical Characteristics – Static (continued)**

T<sub>A</sub> = 25°C; input t<sub>r</sub>, t<sub>f</sub> = 20 ns; C<sub>L</sub> = 50 pF; R<sub>L</sub> = 200 kΩ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
I <sub>OH</sub>	Output high (source) current	V <sub>O</sub> = 4.6 V, V <sub>IN</sub> = 0 V, V <sub>DD</sub> = 5 V	T <sub>A</sub> = -55°C	-0.64			mA
			T <sub>A</sub> = -40°C	-0.61			
			T <sub>A</sub> = 25°C	-0.51	-1		
			T <sub>A</sub> = 85°C	-0.42			
			T <sub>A</sub> = 125°C	-0.36			
		V <sub>O</sub> = 2.5 V, V <sub>IN</sub> = 0 V, V <sub>DD</sub> = 5 V	T <sub>A</sub> = -55°C	-2			
			T <sub>A</sub> = -40°C	-1.8			
			T <sub>A</sub> = 25°C	-1.6	-3.2		
			T <sub>A</sub> = 85°C	-1.3			
			T <sub>A</sub> = 125°C	-1.15			
		V <sub>O</sub> = 9.5 V, V <sub>IN</sub> = 0 V, V <sub>DD</sub> = 10 V	T <sub>A</sub> = -55°C	-1.6			
			T <sub>A</sub> = -40°C	-1.5			
			T <sub>A</sub> = 25°C	-1.3	-2.6		
			T <sub>A</sub> = 85°C	-1.1			
			T <sub>A</sub> = 125°C	-0.9			
		V <sub>O</sub> = 13.5 V, V <sub>IN</sub> = 0 V, V <sub>DD</sub> = 15 V	T <sub>A</sub> = -55°C	-4.2			
T <sub>A</sub> = -40°C	-4						
T <sub>A</sub> = 25°C	-3.4		-6.8				
T <sub>A</sub> = 85°C	-2.8						
T <sub>A</sub> = 125°C	-2.4						
V <sub>OL</sub>	Low-level output voltage	V <sub>IN</sub> = 5 V, V <sub>DD</sub> = 5 V	T <sub>A</sub> = 25°C		0	0.05	V
			All other temperatures			0.05	
	V <sub>IN</sub> = 10 V, V <sub>DD</sub> = 10 V	T <sub>A</sub> = 25°C		0	0.05		
		All other temperatures			0.05		
	V <sub>IN</sub> = 15 V, V <sub>DD</sub> = 15 V	T <sub>A</sub> = 25°C		0	0.05		
		All other temperatures			0.05		
V <sub>OH</sub>	High-level output voltage	V <sub>IN</sub> = 0 V, V <sub>DD</sub> = 5 V	T <sub>A</sub> = 25°C	4.95	5		V
			All other temperatures	4.95			
	V <sub>IN</sub> = 0 V, V <sub>DD</sub> = 10 V	T <sub>A</sub> = 25°C	9.95	10			
		All other temperatures	9.95				
	V <sub>IN</sub> = 0 V, V <sub>DD</sub> = 15 V	T <sub>A</sub> = 25°C	14.95	15			
		All other temperatures	14.95				
V <sub>IL</sub>	Input low voltage	V <sub>O</sub> = 4.5 V, V <sub>DD</sub> = 5 V, all temperatures				1	V
		V <sub>O</sub> = 9 V, V <sub>DD</sub> = 10 V, all temperatures				2	
		V <sub>O</sub> = 13.5 V, V <sub>DD</sub> = 15 V, all temperatures				2.5	
V <sub>IH</sub>	Input high voltage	V <sub>O</sub> = 0.5 V, V <sub>DD</sub> = 5 V, all temperatures		4			V
		V <sub>O</sub> = 1 V, V <sub>DD</sub> = 10 V, all temperatures		8			
		V <sub>O</sub> = 1.5 V, V <sub>DD</sub> = 15 V, all temperatures		12.5			

**Electrical Characteristics – Static (continued)**
 $T_A = 25^\circ\text{C}$ ; input  $t_r, t_f = 20\text{ ns}$ ;  $C_L = 50\text{ pF}$ ;  $R_L = 200\text{ k}\Omega$  (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$I_{IN}$ Input current	$V_{IN} = 0\text{ V to }18\text{ V}, V_{DD} = 18\text{ V}$	$T_A = -55^\circ\text{C}$		$\pm 01$	$\mu\text{A}$
		$T_A = -40^\circ\text{C}$		$\pm 01$	
		$T_A = 25^\circ\text{C}$		$\pm 10^{-5}$	
		$T_A = 85^\circ\text{C}$		$\pm 1$	
		$T_A = 125^\circ\text{C}$		$\pm 1$	

## 6.7 Typical Characteristics

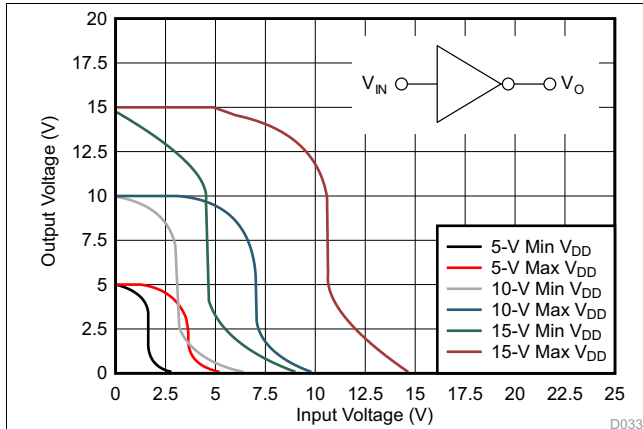


Figure 1. Minimum and Maximum Voltage Transfer Characteristics

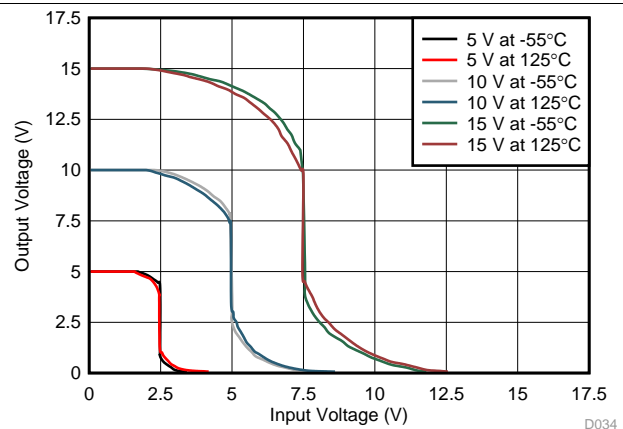


Figure 2. Typical Voltage Transfer Characteristics as a Function of Temperature

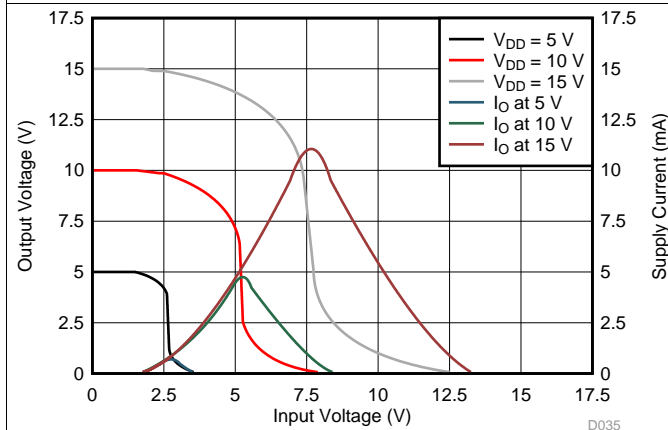


Figure 3. Typical Current and Voltage Transfer Characteristics

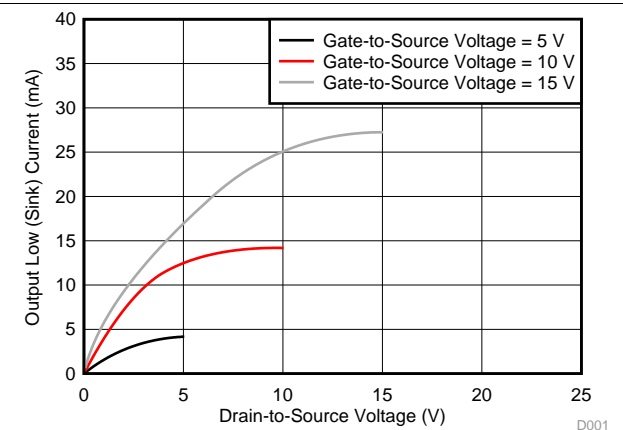


Figure 4. Typical Output Low (Sink) Current Characteristics

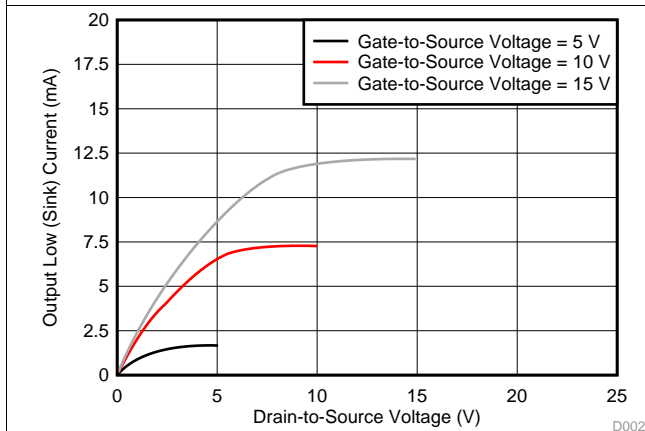


Figure 5. Minimum Output Low (Sink) Current Characteristics

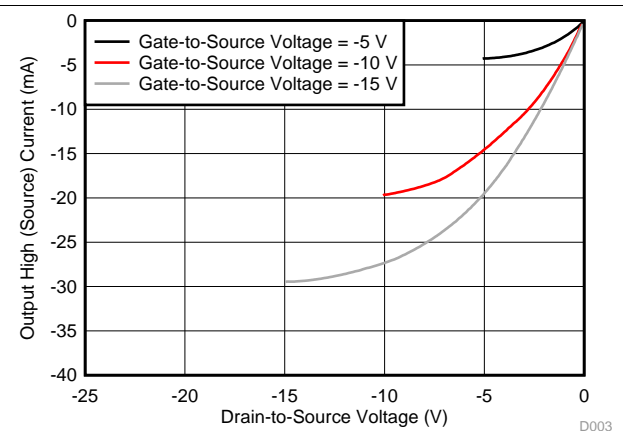
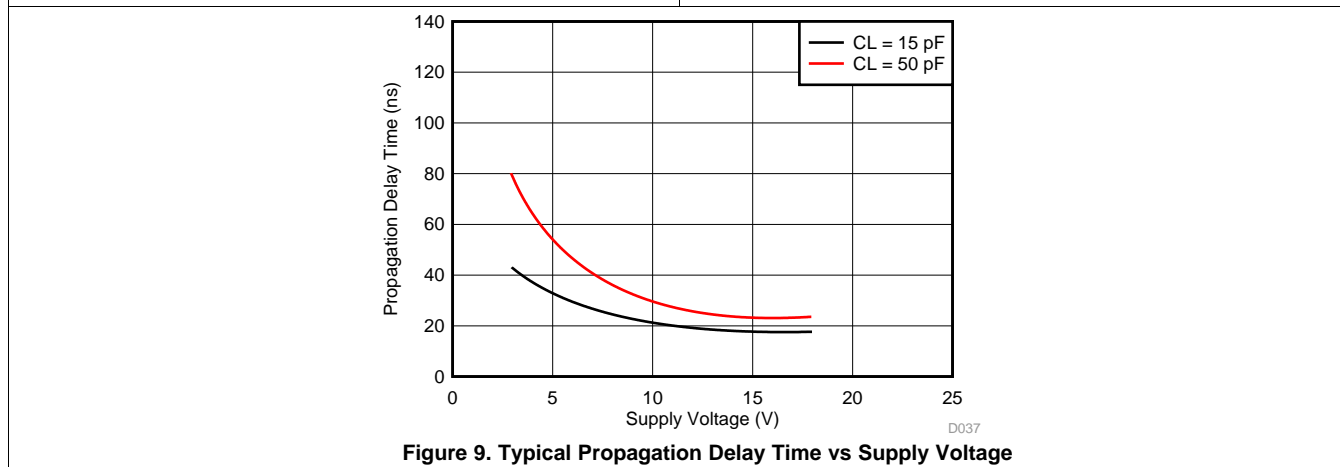
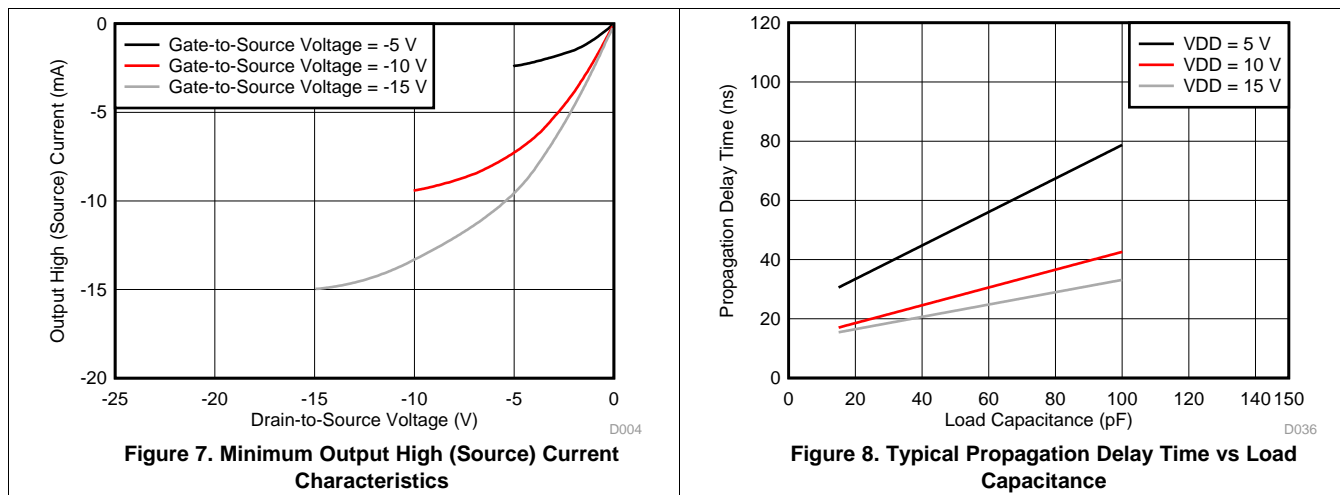


Figure 6. Typical Output High (Source) Current Characteristics



Typical Characteristics (continued)



7 Parameter Measurement Information

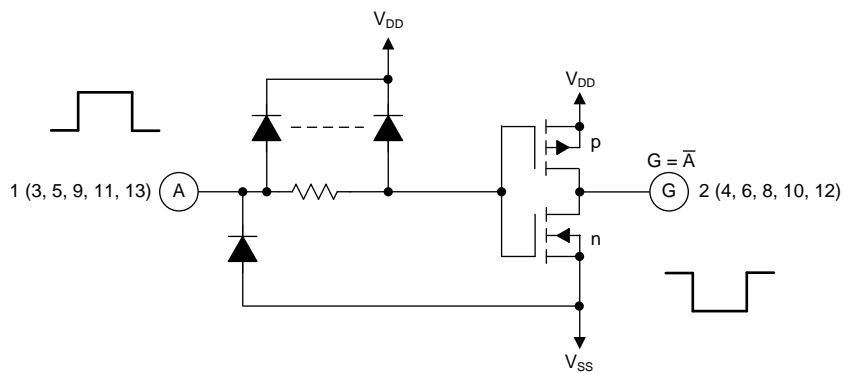
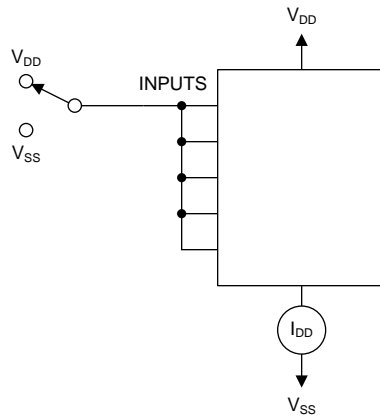
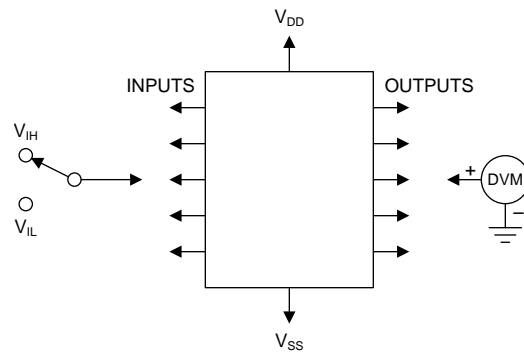


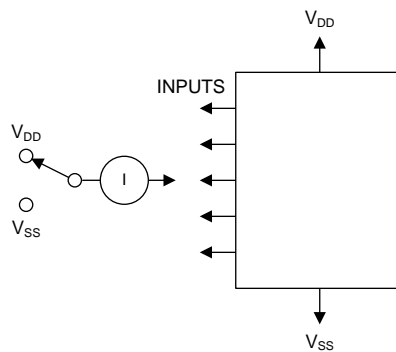
Figure 10. Schematic Diagram of One of Six Identical Inverters



**Figure 11. Quiescent Device Current Test Circuit**



**Figure 12. Noise Immunity Test Circuit**



**Figure 13. Input Leakage Current Test Circuit**

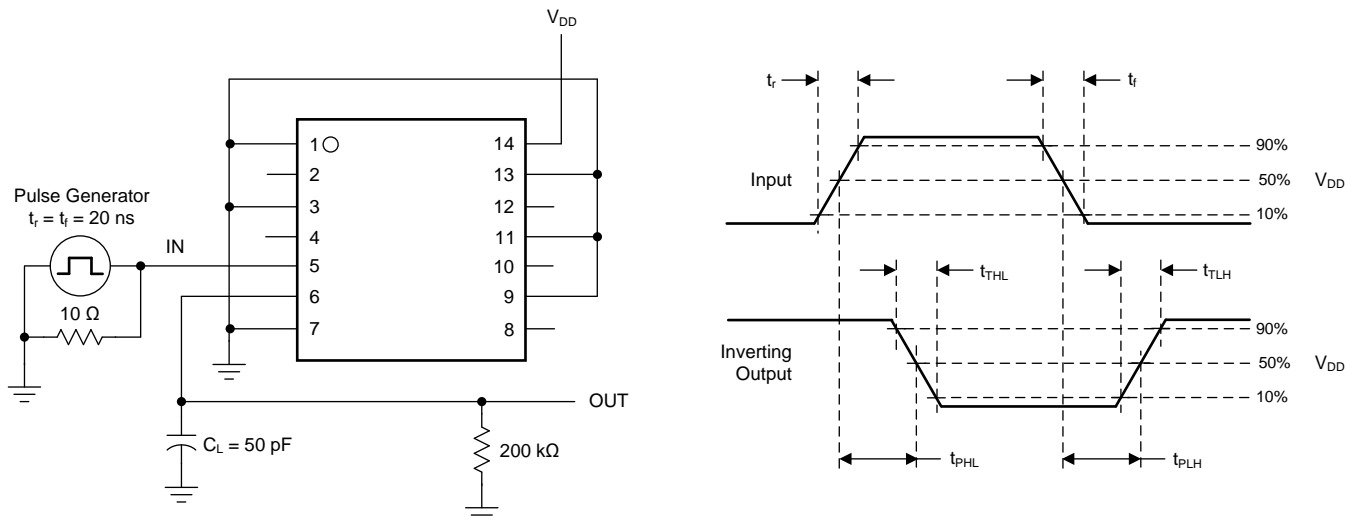


Figure 14. Dynamic Electrical Characteristics Test Circuit and Waveform

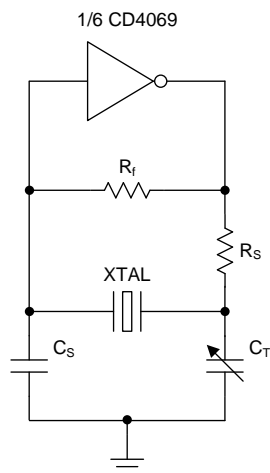


Figure 15. Typical Crystal Oscillator Circuit

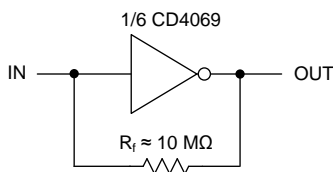


Figure 16. High-Input Impedance Amplifier

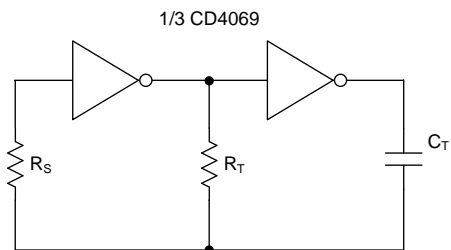
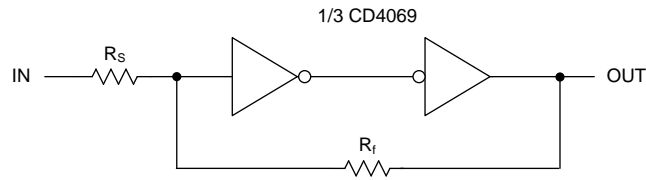


Figure 17. Typical RC Oscillator Circuit



Upper Switching Point :

$$V_P = \frac{R_S + R_f}{R_f} \times \frac{V_{DD}}{2}$$

Lower Switching Point :

$$V_N = \frac{R_f - R_S}{R_f} \times \frac{V_{DD}}{2}$$

$$R_f > R_S$$

Figure 18. Input Pulse Shaping Circuit

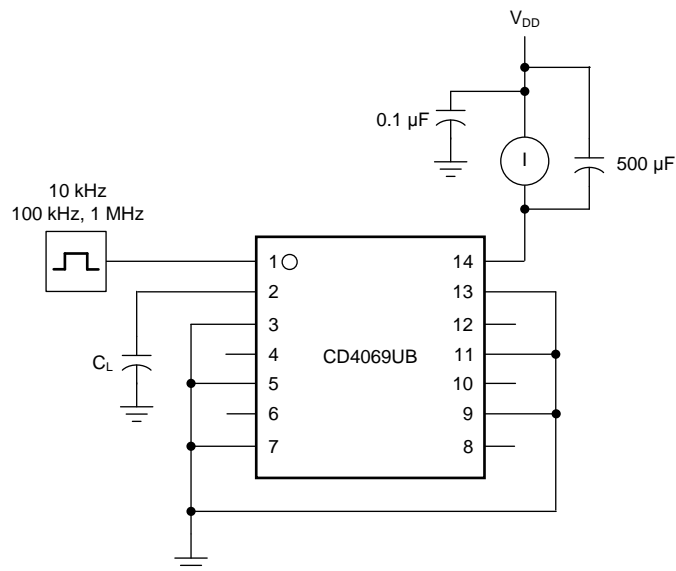


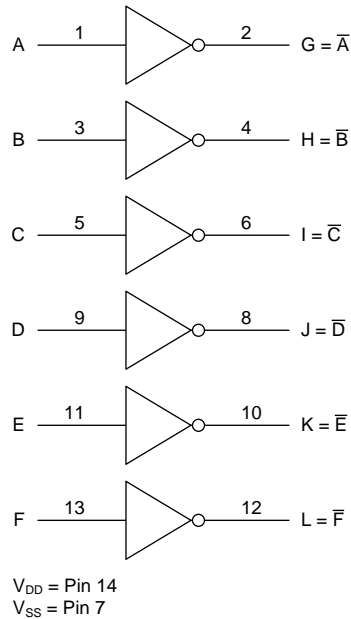
Figure 19. Dynamic Power Dissipation Test Circuit

## 8 Detailed Description

### 8.1 Overview

The CD4069UB device has six inverter circuits. The recommended operating range is from 3 V to 18 V. The CD4069UB-series types are supplied in 14-pin hermetic dual-in-line ceramic packages (F3A suffix), 14-pin dual-in-line plastic packages (E suffix), 14-pin small-outline packages (M, MT, M96, and NSR suffixes), and 14-pin thin shrink small-outline packages (PW and PWR suffixes).

### 8.2 Functional Block Diagram



### 8.3 Feature Description

CD4069UB has standardized symmetrical output characteristics and a wide operating voltage range from 3 V to 18 V with quiescent current tested at 20 V. This has a medium operation speed of  $t_{PHL}$ ,  $t_{PLH} = 30$  ns (typical) at 10 V. The operating temperature is from  $-55^{\circ}\text{C}$  to  $125^{\circ}\text{C}$ . CD4069UB meets all requirements of JEDEC tentative standard No. 13B, *Standard Specifications for Description of B Series CMOS Devices*.

### 8.4 Device Functional Modes

Table 1 shows the functional modes for CD4069UB.

Table 1. Function Table

INPUT A, B, C, D, E, F	OUTPUT G, H, I, J, K, L
H	L
L	H

## 9 Application and Implementation

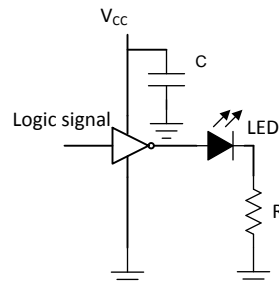
### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 9.1 Application Information

The CD4069UB device has a low input current of 1  $\mu\text{A}$  at 18 V over full package-temperature range and 100 nA at 18 V, 25°C. This device has a wide operating voltage range from 3 V to 18 V and used in high voltage applications.

### 9.2 Typical Application



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**Figure 20. CD4069UB Application**

#### 9.2.1 Design Requirements

The CD4069UB device is the industry's highest logic inverter operating at 18 V under recommended conditions. The lower drive capabilities makes it suitable for driving light loads like LED and greatly reduces chances of overshoots and undershoots.

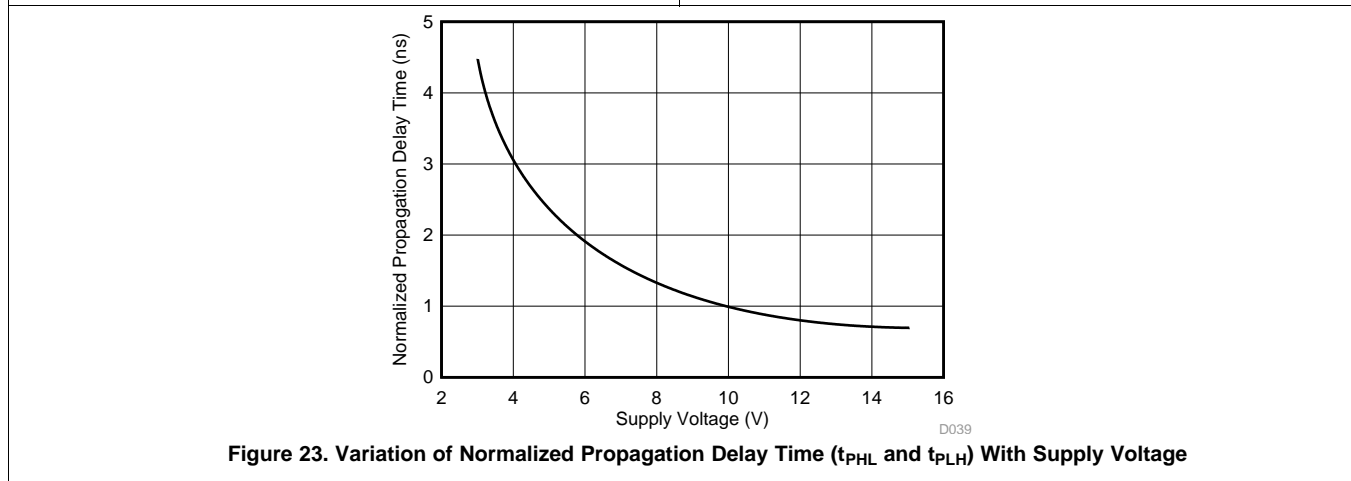
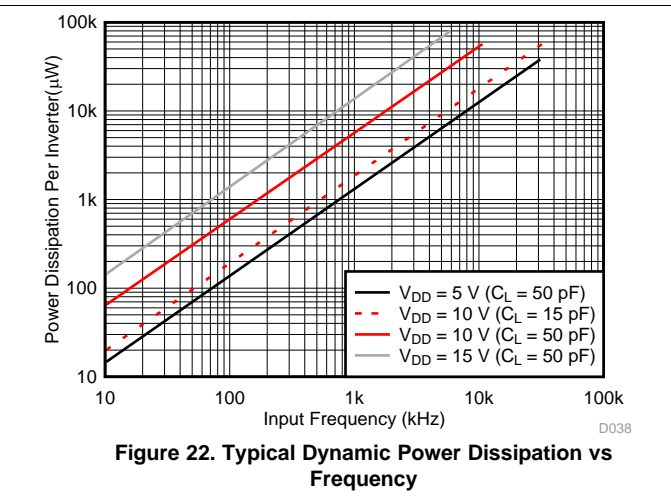
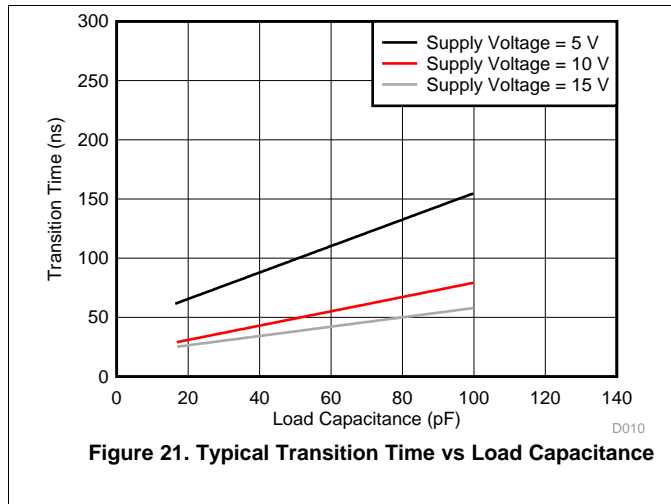
#### 9.2.2 Detailed Design Procedure

The recommended input conditions for [Figure 20](#) includes rise time and fall time specifications (see  $\Delta t/\Delta V$  in [Recommended Operating Conditions](#)) and specified high and low levels (see  $V_{IH}$  and  $V_{IL}$  in [Recommended Operating Conditions](#)). Inputs are not overvoltage tolerant and must be below  $V_{CC}$  level because of the presence of input clamp diodes to  $V_{CC}$ .

The recommended output condition for the CD4069UB application includes specific load currents. Load currents must be limited so as to not exceed the total power (continuous current through  $V_{CC}$  or GND) for the device. These limits are located in the [Absolute Maximum Ratings](#). Outputs must not be pulled above  $V_{CC}$ .

Typical Application (continued)

9.2.3 Application Curves



## 10 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in [Recommended Operating Conditions](#).

Each  $V_{CC}$  pin must have a good bypass capacitor to prevent power disturbance. For devices with a single supply, TI recommends a 0.1- $\mu\text{F}$  capacitor. If there are multiple  $V_{CC}$  pins, then TI recommends a 0.01- $\mu\text{F}$  or 0.022- $\mu\text{F}$  capacitor for each power pin. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. 0.1- $\mu\text{F}$  and 1- $\mu\text{F}$  capacitors are commonly used in parallel. The bypass capacitor must be installed as close to the power pin as possible for best results.

## 11 Layout

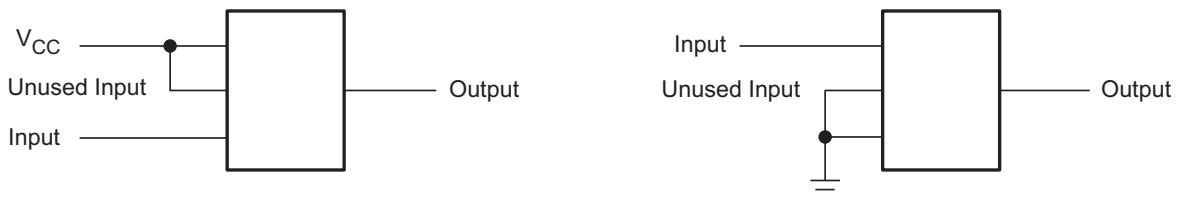
### 11.1 Layout Guidelines

When using multiple bit logic devices, inputs must never float.

In many cases, digital logic device functions or parts of these functions are unused (for example, when only two inputs of a triple-input and gate are used, or only 3 of the 4 buffer gates are used). Such input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. This rule must be observed under all circumstances specified in the next paragraph.

All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. See the application note, [Implications of Slow or Floating CMOS Inputs \(SCBA004\)](#), for more information on the effects of floating inputs. The logic level must apply to any particular unused input depending on the function of the device. Generally, they are tied to GND or  $V_{CC}$  (whichever is convenient).

### 11.2 Layout Example





## 12 デバイスおよびドキュメントのサポート

### 12.1 デバイス・サポート

#### 12.1.1 デベロッパー・ネットワークの製品に関する免責事項

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### 12.2 ドキュメントのサポート

#### 12.2.1 関連資料

関連資料については、以下を参照してください。

- 『低速またはフローティングCMOS入力の影響』、SCBA004

### 12.3 コミュニティ・リソース

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

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### 12.4 商標

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### 12.6 Glossary

[SLYZ022](#) — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

## 13 メカニカル、パッケージ、および注文情報

以降のページには、メカニカル、パッケージ、および注文に関する情報が記載されています。この情報は、そのデバイスについて利用可能な最新のデータです。このデータは予告なく変更されることがあり、ドキュメントが改訂される場合もあります。本データシートのブラウザ版を使用されている場合は、画面左側の説明をご覧ください。

**PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CD4069UBE	ACTIVE	PDIP	N	14	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD4069UBE	<a href="#">Samples</a>
CD4069UBEE4	ACTIVE	PDIP	N	14	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD4069UBE	<a href="#">Samples</a>
CD4069UBF	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	CD4069UBF	<a href="#">Samples</a>
CD4069UBF3A	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	CD4069UBF3A	<a href="#">Samples</a>
CD4069UBM	ACTIVE	SOIC	D	14	50	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4069UBM	<a href="#">Samples</a>
CD4069UBM96	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU   SN	Level-1-260C-UNLIM	-55 to 125	CD4069UBM	<a href="#">Samples</a>
CD4069UBMT	OBSOLETE	SOIC	D	14		TBD	Call TI	Call TI	-55 to 125	CD4069UBM	
CD4069UBNSR	ACTIVE	SO	NS	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4069UB	<a href="#">Samples</a>
CD4069UBPW	OBSOLETE	TSSOP	PW	14		TBD	Call TI	Call TI	-55 to 125	CM069UB	
CD4069UBPWR	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU   SN	Level-1-260C-UNLIM	-55 to 125	CM069UB	<a href="#">Samples</a>
JM38510/17401BCA	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	JM38510/ 17401BCA	<a href="#">Samples</a>
M38510/17401BCA	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	JM38510/ 17401BCA	<a href="#">Samples</a>

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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**OTHER QUALIFIED VERSIONS OF CD4069UB, CD4069UB-MIL :**

- Catalog : [CD4069UB](#)
- Military : [CD4069UB-MIL](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product
- Military - QML certified for Military and Defense Applications

**TAPE AND REEL INFORMATION**

**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD4069UBM96	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
CD4069UBM96	SOIC	D	14	2500	330.0	16.8	6.5	9.5	2.1	8.0	16.0	Q1
CD4069UBNSR	SO	NS	14	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
CD4069UBPWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
CD4069UBPWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

**TAPE AND REEL BOX DIMENSIONS**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD4069UBM96	SOIC	D	14	2500	356.0	356.0	35.0
CD4069UBM96	SOIC	D	14	2500	364.0	364.0	27.0
CD4069UBNSR	SO	NS	14	2000	356.0	356.0	35.0
CD4069UBPWR	TSSOP	PW	14	2000	364.0	364.0	27.0
CD4069UBPWR	TSSOP	PW	14	2000	356.0	356.0	35.0

**TUBE**


\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
CD4069UBE	N	PDIP	14	25	506	13.97	11230	4.32
CD4069UBE	N	PDIP	14	25	506	13.97	11230	4.32
CD4069UBEE4	N	PDIP	14	25	506	13.97	11230	4.32
CD4069UBEE4	N	PDIP	14	25	506	13.97	11230	4.32
CD4069UBM	D	SOIC	14	50	506.6	8	3940	4.32

# MECHANICAL DATA

NS (R-PDSO-G\*\*)

PLASTIC SMALL-OUTLINE PACKAGE

14-PINS SHOWN



- NOTES:
- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.

J 14

**GENERIC PACKAGE VIEW**  
**CDIP - 5.08 mm max height**  
CERAMIC DUAL IN LINE PACKAGE



Images above are just a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.

4040083-5/G



J0014A



# PACKAGE OUTLINE

CDIP - 5.08 mm max height

CERAMIC DUAL IN LINE PACKAGE



4214771/A 05/2017

NOTES:

1. All controlling linear dimensions are in inches. Dimensions in brackets are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This package is hermetically sealed with a ceramic lid using glass frit.
4. Index point is provided on cap for terminal identification only and on press ceramic glass frit seal only.
5. Falls within MIL-STD-1835 and GDIP1-T14.

# EXAMPLE BOARD LAYOUT

J0014A

CDIP - 5.08 mm max height

CERAMIC DUAL IN LINE PACKAGE



LAND PATTERN EXAMPLE  
NON-SOLDER MASK DEFINED  
SCALE: 5X



4214771/A 05/2017



D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



4211283-3/E 08/12

- NOTES:
- All linear dimensions are in millimeters.
  - This drawing is subject to change without notice.
  - Publication IPC-7351 is recommended for alternate designs.
  - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
  - Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
  - B. This drawing is subject to change without notice.
  -  Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
  -  Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
  - E. Falls within JEDEC MO-153

N (R-PDIP-T\*\*)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- NOTES:
- A. All linear dimensions are in inches (millimeters).
  - B. This drawing is subject to change without notice.
  - Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
  - The 20 pin end lead shoulder width is a vendor option, either half or full width.

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